Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	Applicant(s)/Patent under Reexamination	
10/896,528	LIN ET AL.		
Examiner	Art Unit		
Sam IN Chan	2811		

SEARCHED			
Class	Subclass	Date	Examiner
257	360 361	3105	SWC.
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SEARCH NOTES				
(INCLUDING SEARCH STRATEGY)				
EAST	DATE	EXMR		
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update	12/05	SWC		
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